

<b>Notice of References Cited</b>	Application/Control No. 09/865,952	Applicant(s)/Patent Under Reexamination XU, JIANPING	
	Examiner David Y. Jung	Art Unit 2134	Page 1 of 1

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*	C	US-6,731,270	05-2004	Tosaya, Carol A.	345/173
*	D	US-6,724,371	04-2004	Shenholtz et al.	345/177
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	<a href="http://sketch.inesc-id.pt/technicalreports/D05.pdf">http://sketch.inesc-id.pt/technicalreports/D05.pdf</a> , pages 1-5, 40-57
	V	<a href="http://www.ischool.berkeley.edu/~ping/peep/yee-peep-chi2003-paper.pdf">http://www.ischool.berkeley.edu/~ping/peep/yee-peep-chi2003-paper.pdf</a>
	W	<a href="http://privatewww.essex.ac.uk/~fleum/VIev2.pdf">http://privatewww.essex.ac.uk/~fleum/VIev2.pdf</a>
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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